

Welcome United States Patent and Trademark Office

□□ Advanced Search

BROWSE

SEARCH

IEEE XPLORE GUIDE

	in All Fields	
AND 🔯	in All Fields	
AND 🔀	in All Fields	
OPTION 2	•	

0

steam <sentence> turbine) <and> (inspect 🖺</and></sentence>
or> detect <or> performance) <and></and></or>
nutdown

- » Note: You may use the search operators <and> or <or> without the start and end brackets <>.
- » Learn more about Field Codes, Search Examples, and Search Operators

» Publications

Select publications

✓ IEEE Periodicals

✓ IEE Periodicals

IEEE Conference Proceeding

✓ IEE Conference Proceeding:

✓ IEEE Standards

» Other Resources (Available for Pure

▼ IEEE Books

» Select date range

C Search latest content update (25

From year All to Present

» Display Format

Citation

Citation & Abstra

» Organize results

Maximum	100 🔽	
Display	25	results per p
Sort by	Relevance	
In	Descendin	g 🔽 order

Help Contact Us Privacy &:

© Copyright 2005 IEEE -

Indexed by #Inspec



Welcome United States Patent and Trademark Office

□ View Selected Items

BROWSE

SEARCH

IEEE XPLORE GUIDE

Results for " (((steam <sentence> turbine) <and> (inspect <or> detect <or> performance) &l... " Your search matched 1 of 1194402 documents. You selected 1 items.

☑ e-mail

» Download Citations

Citation ∇

EndNote,ProCite,RefMan 🔯 🤉

» Learn more

» Key

IEEE JNL

IEEE Journal or

Magazine

IEE JNL

IEE Journal or Magazine

IEEE CNF

IEEE Conference

Proceeding

IEE CNF

IEE Conference

Proceeding

IEEE STD IEEE Standard

Display Format:

Citation Citation & Abstract

Article Information

View: 1-1 | View

Vision system for turbine inspection

Maliniemi, H.; Ailisto, H.; Hakalahti, H.

Pattern Recognition, 1988., 9th International Conference on

14-17 Nov 1988

Page(s): 1202-1206 vol.2

Digital Object Identifier 10.1109/ICPR.1988.28471

Summary: An image analysis method was developed for the inspection of rotating bla turbines. The method consists of three parts: (1) detecting the eventual crack points, (2)

cluster of these points, i.e. the eventual crack; and (3) fo.....

AbstractPlus | Full Text: PDF | IEEE CNF

View: 1-1 | View Search Resi

Help Contact Us Privacy &:

© Copyright 2005 IEEE -

Indexed by



Welcome United States Patent and Trademark Office

BROWSE

SEARCH'

IEEE XPLORE GUIDE

©	OPTION 1 Enter keywords or phrases, select fields, and select ope	» Publications erators
		(Select publications
	in All Fields	
	AND 🕶 in All Fields	✓ IEE Periodicals
		TELE COMOTONICO FICACCONIC
	AND in All Fields	IEE Conference Proceeding
		▼ IEEE Standards
		» Other Resources (Available for Pur
(9)	OPTION 2 Enter keywords, phrases, or a Boolean expression	▼ IEEE Books
	steam <and> turbine <and> shutdown</and></and>	» Select date range
		© Search latest content update (25
	•	● From year All
	- Lake and - September - Septe	to Present 👻
		•
		» Display Format

- » Note: You may use the search operators <and> or <or> without the start and end brackets <>.
- » Learn more about Field Codes, Search Examples, and Search Operators

» Organize results

Maximum 100 Property Property

Help Contact Us Privacy & © Copyright 2005 IEEE -

Indexed by Inspec

⊠e-mail

>>



Home | Login | Logout | Access Information | Alerts |

Welcome United States Patent and Trademark Office

☐ Search Results

BROWSE

SEARCH

IEEE XPLORE GUIDE

Results for "((steam <and> turbine <and> shutdown)<in>metadata)"

Your search matched 3 of 1194402 documents.

A maximum of 100 results are displayed, 25 to a page, sorted by Relevance in Descending order.

» Search Options

View Session History

New Search

» Key

IEEE JNL

IEEE Journal or Magazine

IEE JNL

IEE Journal or Magazine

IEEE CNF

IEEE Conference Proceeding

IEE CNF

IEE Conference Proceeding

IEEE STD IEEE Standard

Modify Search

((steam <and> turbine <and> shutdown)<in>metadata)

Check to search only within this results set

Display Format:

© Citation C Citation & Abstract

Select Article Information

1. Sequential tripping of steam turbine generators

Fennell, E.; Kozminski, K.; Bajpai, M.; Easterday-McPadden, S.; Elmore, W.; F Gardell, J.; Hartmann, W.; Hurley, J.; Kerrigan, P.; Khunkhun, K.; Mozina, C.; I

3. IEEE guide for protection, interlocking, and control of fossil-fueled unit-c

Pence, G.; Pierce, A.; Smaha, D.; Usman, S.; Waudby, P.; Yalla, M.;

Power Delivery, IEEE Transactions on

Volume 14, Issue 1, Jan. 1999 Page(s):132 - 141

Digital Object Identifier 10.1109/61.736702

AbstractPlus | Full Text: PDF(868 KB) IEEE JNL

2. Vision system for turbine inspection

Maliniemi, H.; Ailisto, H.; Hakalahti, H.;

Pattern Recognition, 1988., 9th International Conference on

14-17 Nov. 1988 Page(s):1202 - 1206 vol.2

Digital Object Identifier 10.1109/ICPR.1988.28471 AbstractPlus | Full Text: PDF(400 KB) | IEEE CNF

stations

IEEE Std 502-1985

10 June 1985

AbstractPlus | Full Text: PDF(844 KB) IEEE STD

Contact Us Privacy &:

Copyright 2005 IEEE -

Indexed by # Inspec



Welcome United States Patent and Trademark Office

BROWSE

SEARCH

IEEE XPLORE GUIDE

©	OPTION 1 Enter keywords or phrases, select fields, and select operators	» Publications© Select publications
©	OPTION 2 Enter keywords, phrases, or a Boolean expression	» Other Resources (Available for Pur ✓ IEEE Books
	steam <sentence> turbine <and> inspect <or> detect <or> performance <and> shutdown <and> disassemble <or></or></and></and></or></or></and></sentence>	» Select date range © Search latest content update (25)

- Latita Las
- » Note: You may use the search operators <and> or <or> without the start and end brackets <>.

disassembling <or> disassembly

» Learn more about Field Codes, Search Examples, and Search Operators

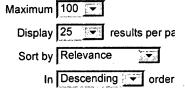
» Display Format

From year All

Citation

C Citation & Abstr

» Organize results



to Present 🔽

Help Contact Us Privacy & © Copyright 2005 IEEE –

Indexed by



Welcome United States Patent and Trademark Office

RELEASE 2.1		welcome united States	Patent and Trader	пагк Опісе
Search Results		BROWSE	SEARCH	IEEE XPLORE GUIDE
Results for "((steam <sentence> t Your search matched 32248 of 119 A maximum of 100 results are disp</sentence>	4402 docume	nts.		_
» Search Options				
View Session History		fy Search		
New Search	((stea	m <sentence> turbine <and> ir</and></sentence>	nspect <or> detect <o< td=""><td>r> performance <and> shut</and></td></o<></or>	r> performance <and> shut</and>
•	□с	heck to search only within t	his results set	
» Other Resources (Available For Purchase)	Displ	ay Format: 6 Citation	C Citation & Ab	stract
Top Book Results	Select	Article Information		View: 1-25 26-5
The Pattern Recognition Basis of Artificial Intelligence by Tveter, D.; Computer Algorithms by Aoe, JI.;	· 🗀	Disassembly sequence Hong-Seok Park; Hung- Science and Technolog Symposium on Volume 1, 28 June-6 June-6 June-10	-Won Choi; Hak-So y, 2003. Proceedin	o Mok; gs KORUS 2003. The 7th Korea-Ru
Integrated Circuit Manufacturability by Gyvez, J. P. D.; Pradhan, D.;		AbstractPlus Full Text		
Power System Protection by Anderson, P. M.; Electromyography by Merletti, R.; Parker, P.; View All 10 Result(s)		strategies and design Yamagiwa, Y.; Numata Management of Engine Conference on Volume 1, 29 July-2 Au Digital Object Identifier	enabling both eas , J.; Namiki, Y.; ering and Technolo ug. 2001 Page(s):49 10.1109/PICMET.2	001.952403
» Key		AbstractPlus Full Text	: <u>PDF(</u> 112 KB) IE	EE CNF
IEEE JNL IEEE Journal or Magazine IEE JNL IEE Journal or Magazine IEEE CNF IEEE Conference Proceeding IEE CNF IEE Conference		systems Gadh, R.; Srinivasan, H Reliability and Maintain 19-22 Jan. 1998 Page(s Digital Object Identifier	I.; Nuggehalli, S.; F ability Symposium, s):120 - 125 10.1109/RAMS.199	1998. Proceedings., Annual 98.653676
Proceeding		AbstractPlus Full Text	: <u>PDF(</u> 704 KB) IE	EE CNF
IEEE STD IEEE Standard	Γ	4. Selective disassembly Shyamsundar, N.; Gadl Systems, Man, and Cyt Volume 4, 14-17 Oct. 1 Digital Object Identifier AbstractPlus Full Text	h, R.; bernetics, 1996., IE 1996 Page(s):3159 10.1109/ICSMC.19	EE International Conference on - 3164 vol.4 96.561491
		5. Quantitative disassen		

Symposium on

6-8 May 1996 Page(s):19 - 24

Digital Object Identifier 10.1109/ISEE.1996.500390

<u>AbstractPlus</u> | Full Text: <u>PDF</u>(564 KB) | IEEE CNF

Electronics and the Environment, 1996. ISEE-1996., Proceedings of the 1996 I

r:	6. A new strategy for a flexible semi-automatic disassembling cell of printed Zebedin, H.; Daichendt, K.; Kopacek, P.; Industrial Electronics, 2001. Proceedings. ISIE 2001. IEEE International Sympology Volume 3, 12-16 June 2001 Page(s):1742 - 1746 vol.3 Digital Object Identifier 10.1109/ISIE.2001.931972
	AbstractPlus Full Text: PDF(416 KB) IEEE CNF
	 Disassembly Petri net generation in the presence of XOR precedence relations. Moore, K.E.; Gungor, A.; Gupta, S.M.; Systems, Man, and Cybernetics, 1998. 1998 IEEE International Conference or Volume 1, 11-14 Oct 1998 Page(s):13 - 18 vol.1 Digital Object Identifier 10.1109/ICSMC.1998.725376
	AbstractPlus Full Text: PDF(440 KB) IEEE CNF
П	 A methodology for modeling and adaptive planning of disassembly proce Zussman, E.; Zhou, M.; Robotics and Automation, IEEE Transactions on Volume 15, Issue 1, Feb. 1999 Page(s):190 - 194 Digital Object Identifier 10.1109/70.744614
	AbstractPlus References Full Text: PDF(224 KB) IEEE JNL
	 Disassembly factories: economic and environmental options Ewers, HJ.; Schatz, M.; Fleischer, G.; Dose, J.; Assembly and Task Planning, 2001, Proceedings of the IEEE International Syr 28-29 May 2001 Page(s):447 - 452 Digital Object Identifier 10.1109/ISATP.2001.929075
	AbstractPlus Full Text: PDF(524 KB) IEEE CNF
	10. A graph-based approach to disassembly model for end-of-life product red Zhang, H.C., Kuo, T.C., Electronics Manufacturing Technology Symposium, 1996., Nineteenth IEEE/C 14-16 Oct. 1996 Page(s):247 - 254 Digital Object Identifier 10.1109/IEMT.1996.559739
	AbstractPlus Full Text: PDF(888 KB) IEEE CNF
	11. Disassembly of executable code revisited Schwarz, B.; Debray, S.; Andrews, G.; Reverse Engineering, 2002. Proceedings. Ninth Working Conference on 29 Oct1 Nov. 2002 Page(s):45 - 54 Digital Object Identifier 10.1109/WCRE.2002.1173063 AbstractPlus Full Text: PDF(323 KB) IEEE CNF
·	12. Test compaction for synchronous sequential circuits by test sequence report Pomeranz, I.; Reddy, S.M.; VLSI, 1998. Proceedings of the 8th-Great Lakes Symposium on 19-21 Feb. 1998 Page(s):216 - 221 Digital Object Identifier 10.1109/GLSV.1998.665229 AbstractPlus Full Text: PDF(44 KB) IEEE CNF
	13. Lean disassembly line layout, and network simulation models Ranky, P.G.; Morales, L.C.; Caudill, R.J.; Electronics and the Environment, 2003. IEEE International Symposium on 19-22 May 2003 Page(s):36 - 41 Digital Object Identifier 10.1109/ISEE.2003.1208044 AbstractPlus Full Text: PDF(388 KB) IEEE CNF

Γ	14. Active disassembly and reversible interconnection Suga, T.; Hosoda, N.;
	Electronics and the Environment, 2000. ISEE 2000. Proceedings of the 2000 I Symposium on
	8-10 May 2000 Page(s):330 - 334 Digital Object Identifier 10.1109/ISEE.2000.857670
	AbstractPlus Full Text: PDF(404 KB) IEEE CNF
	15. Disassemblability assessment for IM Suga, T.;
	Environmentally Conscious Design and Inverse Manufacturing, 1999. Proceed '99: First International Symposium On 1-3 Feb. 1999 Page(s):580 - 581 Digital Object Identifier 10.1109/ECODIM.1999.747678
	AbstractPlus Full Text: PDF(188 KB) IEEE CNF
,J	16. Disassembly simulation for an effective recycling of electrical scrap Hesselbach, J.; von Westernhagen, K.; Environmentally Conscious Design and Inverse Manufacturing, 1999. Proceed '99: First International Symposium On 1-3 Feb. 1999 Page(s):582 - 585 Digital Object Identifier 10.1109/ECODIM.1999.747679
	AbstractPlus Full Text: PDF(244 KB) IEEE CNF
	17. Complexity reduction in geometric selective disassembly using the wave abstraction Srinivasan, H.; Gadh, R.; Robotics and Automation, 1998. Proceedings. 1998 IEEE International Confer Volume 2, 16-20 May 1998 Page(s):1478 - 1483 vol.2 Digital Object Identifier 10.1109/ROBOT.1998.677315
	AbstractPlus Full Text: PDF(584 KB) IEEE CNF
	18. Optimum disassembly sequence with sequence-dependent disassembly Lambert, A.J.D.;
	Assembly and Task Planning, 2003. Proceedings of the IEEE International Syr 10-11 July 2003 Page(s):151 - 156 Digital Object Identifier 10.1109/ISATP.2003.1217203
	AbstractPlus Full Text: PDF(435 KB) IEEE CNF
<u> </u>	19. Characterization of material outputs from an electronics demanufacturing Das, S.K.; Matthew, S.;
	Electronics and the Environment, 1999. ISEE -1999. Proceedings of the 1999 International Symposium on 11-13 May 1999 Page(s):251 - 256
	Digital Object Identifier 10.1109/ISEE.1999.765885
	AbstractPlus Full Text: PDF(496 KB) IEEE CNF
	20. Disassembly Petri net approach to modeling and planning disassembly pelectronic products Zussman, E.; Zhou, MC.; Caudill, R.;
	Electronics and the Environment, 1998. ISEE-1998. Proceedings of the 1998 I Symposium on 4-6 May 1998 Page(s):331 - 336 Digital Object Identifier 10.1109/ISEE.1998.675081
	AbstractPlus Full Text: PDF(564 KB) IEEE CNF
Π	21. Dynamic generation of disassembly sequences Martinez, M.; Pham, VH.; Favrel, J.; Emerging Technologies and Fostor, Automotion Presendings, 1997, ETEA 193
	Emerging Technologies and Factory Automation Proceedings, 1997, ETFA '97

International Conference on 9-12 Sept. 1997 Page(s):177 - 182 Digital Object Identifier 10.1109/ETFA.1997.616265 AbstractPlus | Full Text: PDF(508 KB) | IEEE CNF

22. Intelligent decision making in disassembly process based on fuzzy reasc Meimei Gao; MengChu Zhou; Ying Tang; Systems, Man and Cybernetics, Part B, IEEE Transactions on Volume 34, Issue 5, Oct. 2004 Page(s):2029 - 2034 Digital Object Identifier 10.1109/TSMCB.2004.833331 AbstractPlus | References | Full Text: PDF(384 KB) | IEEE JNL

23. A method for dealing with multi-objective optimization problem of disass processes

> Duta, L.; Filip, F.G.; Henrioud, J.-M.; Assembly and Task Planning, 2003. Proceedings of the IEEE International Syr 10-11 July 2003 Page(s):163 - 168

Digital Object Identifier 10.1109/ISATP.2003.1217205

AbstractPlus | Full Text: PDF(352 KB) IEEE CNF

24. On disassembly workshop model integration for disassembly planning Addouche, S.; Perrard, C.; Henrioud, J.-M.; Assembly and Task Planning, 2003. Proceedings of the IEEE International Syr 10-11 July 2003 Page(s):157 - 162 Digital Object Identifier 10.1109/ISATP.2003.1217204

AbstractPlus | Full Text: PDF(441 KB) | IEEE CNF

25. DISX: a procedure for the automated generation of disassembly process Das, S.; Yedlarajiah, D.; Gurram, S.; Electronics and the Environment, 2003. IEEE International Symposium on 19-22 May 2003 Page(s):60 - 65 Digital Object Identifier 10.1109/ISEE.2003.1208048

AbstractPlus | Full Text: PDF(373 KB) IEEE CNF

View: 1-25 | 26-5

Contact Us Privacy &: © Copyright 2005 IEEE -

indexed by # Inspec